



ZXMP6A16DN8

### **Product Summary**

| BV <sub>DSS</sub> | R <sub>DS(ON)</sub> Max         | Package | I <sub>D</sub><br>T <sub>A</sub> = +25°C<br>(Notes 4 & 6) |
|-------------------|---------------------------------|---------|---|
| 601/              | $85m\Omega @ V_{GS} = -10V$     | SO-8    | -3.9A   |
| -60V              | 125mΩ @ V <sub>GS</sub> = -4.5V | 50-8    | -3.2A   |

### Description

This MOSFET has been designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

# Applications

- DC-DC Converters
- Power Management Functions
- Disconnect Switches
- Motor Control

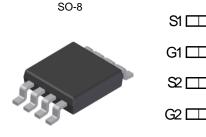
#### Features

- Low On-Resistance
- Fast Switching Speed
- Low Threshold
- Low Gate Drive
- Low Profile SOIC Package
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- An Automotive-Compliant Part is Available Under Separate Datasheet (ZXMP6A16DN8Q)

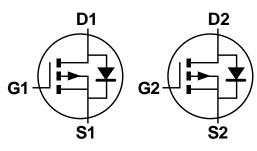
**DUAL P-CHANNEL 60V ENHANCEMENT MODE MOSFET** 

#### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.074 grams (Approximate)



| 0 | 1 D1 |
|---|------|
|   | ⊥ D1 |
|   | □ D2 |
|   | □ D2 |



Equivalent Circuit

#### Ordering Information (Note 4)

Top View

| Part Number   | Case | Packaging         |
|---------------|------|-------------------|
| ZXMP6A16DN8TA | SO-8 | 500/Tape & Reel   |
| ZXMP6A16DN8TC | SO-8 | 2,500/Tape & Reel |

1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.

Top View

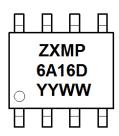
2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

# **Marking Information**

Notes:



ZXMP6A16D = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 16 = 2016) WW = Week (01 - 53)



#### **Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

| Characteristic                         |                       |   | Symbol           | Value | Unit |
|--|-----------------------|---|------------------|-------|------|
| Drain-Source Voltage                   |                       |   | V <sub>DSS</sub> | -60   | V    |
| Gate-Source Voltage (Note 5            |                       |   | V <sub>GS</sub>  | ±20   | V    |
|  |                       | (Notes 7 & 9)                           |                  | -3.9  | A    |
| Continuous Drain Current               | V <sub>GS</sub> = 10V | T <sub>A</sub> = +70°C<br>(Notes 7 & 9) | ID               | -3.1  |      |
|  |                       | (Notes 6 & 9)                           |                  | -2.9  |      |
| Pulsed Drain Current                   |                       | (Notes 8 & 9)                           | IDM              | -18.3 | А    |
| Continuous Source Current (Body Diode) |                       | (Notes 7 & 9)                           | Is               | -3.2  | А    |
| Pulsed Source Current (Body Diode)     |                       | (Notes 8 & 9)                           | I <sub>SM</sub>  | -18.3 | А    |

## **Thermal Characteristics**

| Characteristic                              | Symbol         | Value                | Unit         |            |  |
|---|----------------|----------------------|--------------|------------|--|
|   | (Notes 6 & 9)  |                      | 1.25<br>10.0 |            |  |
| Power Dissipation<br>Linear Derating Factor | (Notes 6 & 10) | PD                   | 1.81<br>14.5 | W<br>mW/°C |  |
|   | (Notes 7 & 9)  |                      | 2.15<br>17   |            |  |
|   | (Notes 6 & 9)  | R <sub>0JA</sub>     | 100          |            |  |
| Thermal Resistance, Junction to Ambient     | (Notes 6 & 10) |                      | 70           | 00444      |  |
|   | (Notes 7 & 9)  |                      | 60           | °C/W       |  |
| Thermal Resistance, Junction to Lead        | (Notes 9 & 11) | R <sub>θJL</sub>     | 48.85        |            |  |
| Operating and Storage Temperature Range     |                | TJ, T <sub>STG</sub> | -55 to +150  | °C         |  |

Notes: 5. AEC-Q101 VGS maximum is  $\pm 16V$ .

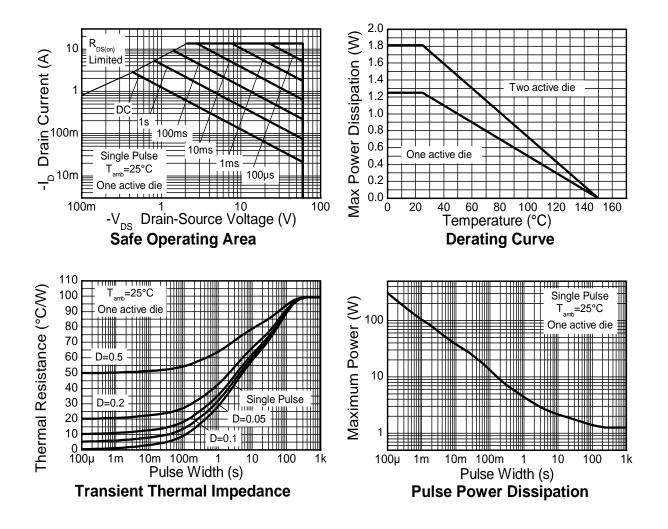
6. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

7. Same as Note (5), except the device is measured at  $t \le 10$  sec. 8. Same as Note (5), except the device is pulsed with D = 0.02 and pulse width 300µs. 9. For a dual device with one active die.

10. For a device with two active die running at equal power.
11. Thermal resistance from junction to solder-point.



## Thermal Characteristics (Continued)





Notes:

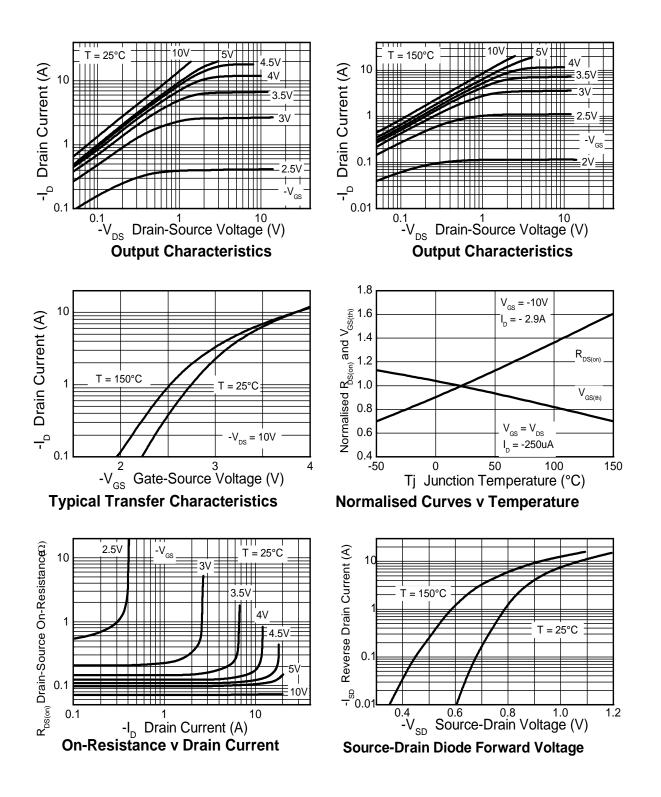
# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

| Characteristic                              | Symbol              | Min  | Тур   | Max   | Unit                           | Test  | Condition                      |
|---|---------------------|------|-------|-------|--------------------------------|---|--------------------------------|
| OFF CHARACTERISTICS                         | - <b>,</b>          |      | - 76  |       |                                |   |                                |
| Drain-Source Breakdown Voltage              | BV <sub>DSS</sub>   | -60  |       |       | V                              | $I_D = -250 \mu A, V_{GS} = 0 V$                                    |                                |
| Zero Gate Voltage Drain Current             | I <sub>DSS</sub>    |      | _     | -1.0  | μA                             | $V_{DS} = -60V, V_{C}$  |                                |
| Gate-Source Leakage                         | I <sub>GSS</sub>    |      | _     | ±100  | nA                             | $V_{GS} = \pm 20 V, V$  | <sub>DS</sub> = 0V             |
| ON CHARACTERISTICS                          |                     |      |       |       |                                |   |                                |
| Gate Threshold Voltage                      | V <sub>GS(TH)</sub> | -1.0 |       |       | V                              | I <sub>D</sub> = -250μA, V  | ds = Vgs                       |
| Static Drain-Source On-Resistance (Note 12) | P                   |      | _     | 85    | $M\Omega = V_{GS} = -10V, I_D$ | = -2.9A   |                                |
|   | R <sub>DS(ON)</sub> |      | _     | 125   | 11122                          | $V_{GS} = -4.5V, I_{E}$   | ) = -2.4A                      |
| Forward Transconductance (Notes 12 & 13)    | <b>g</b> fs         | _    | 7.2   |       | S                              | $V_{DS}$ = -15V, $I_D$  | = -2.9A                        |
| Diode Forward Voltage (Note 12)             | V <sub>SD</sub>     | _    | -0.85 | -0.95 | V                              | $I_{S} = -3.4A, V_{GS}$   | s = 0V, T <sub>J</sub> = +25°C |
| Reverse Recovery Time (Note 13)             | t <sub>RR</sub>     | _    | 29.2  | —     | ns                             | I <sub>S</sub> = -2A, di/dt = 100A/µs,<br>T <sub>J</sub> = +25°C    |                                |
| Reverse Recovery Charge (Note 13)           | Q <sub>RR</sub>     | _    | 39.6  |       | nC                             |   |                                |
| DYNAMIC CHARACTERISTICS (Note 14)           |                     |      |       |       |                                |   |                                |
| Input Capacitance                           | CISS                | _    | 1,021 |       | pF                             | V <sub>DS</sub> = -30V, V <sub>GS</sub> = 0V,<br>- f = 1MHz         |                                |
| Output Capacitance                          | C <sub>OSS</sub>    | _    | 83.1  | —     | pF                             |   |                                |
| Reverse Transfer Capacitance                | C <sub>RSS</sub>    | _    | 56.4  | _     | pF                             |   |                                |
| Total Gate Charge                           | $Q_{G}$             | _    | 12.1  |       | nC                             | $V_{GS} = -5V$  |                                |
| Total Gate Charge                           | $Q_G$               | _    | 24.2  | _     | nC                             | V <sub>DS</sub> = -30V,   | $V_{DS} = -30V,$               |
| Gate-Source Charge                          | Q <sub>GS</sub>     | _    | 2.5   | _     | nC                             | V <sub>GS</sub> = -10V I <sub>D</sub> = -2.9A                       |                                |
| Gate-Drain Charge                           | $Q_{GD}$            | _    | 3.7   | —     | nC                             |   |                                |
| Turn-On Delay Time                          | t <sub>D(ON)</sub>  | _    | 3.5   | _     | ns                             |   |                                |
| Turn-On Rise Time                           | t <sub>R</sub>      |      | 4.1   | _     | ns                             | $V_{DD} = -30V, V_{GS} = -10V,$<br>$I_D = -1A, R_G \cong 6.0\Omega$ |                                |
| Turn-Off Delay Time                         | t <sub>D(OFF)</sub> |      | 35    | _     | ns                             |   |                                |
| Turn-Off Fall Time                          | tF                  |      | 10    | _     | ns                             |   |                                |

Measured under pulsed conditions. Pulse width ≤ 300µs; duty cycle ≤ 2%
For design aid only, not subject to production testing.
Switching characteristics are independent of operating junction temperatures.

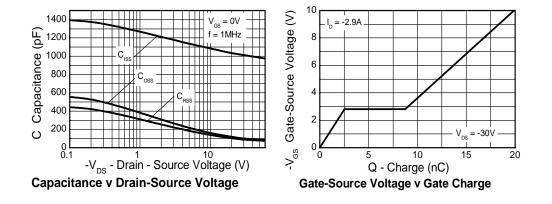


# **Typical Characteristics**

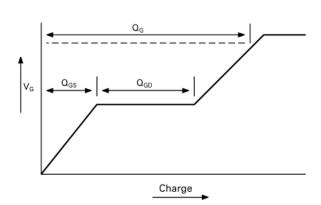




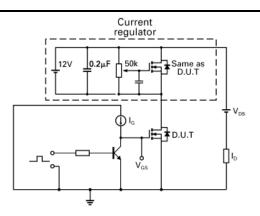
# Typical Characteristics (Continued)



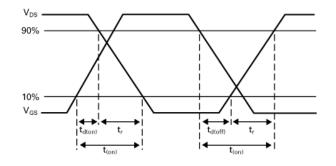
**Test Circuits** 

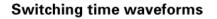


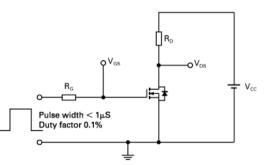
Basic gate charge waveform



Gate charge test circuit





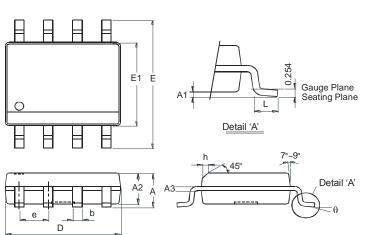


Switching time test circuit



## **Package Outline Dimensions**

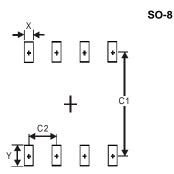
Please see http://www.diodes.com/package-outlines.html for the latest version.



| SO-8                 |      |          |  |  |  |
|----------------------|------|----------|--|--|--|
| Dim                  | Min  | Max      |  |  |  |
| Α                    | -    | 1.75     |  |  |  |
| A1                   | 0.10 | 0.20     |  |  |  |
| A2                   | 1.30 | 1.50     |  |  |  |
| A3                   | 0.15 | 0.25     |  |  |  |
| b                    | 0.3  | 0.5      |  |  |  |
| D                    | 4.85 | 4.95     |  |  |  |
| Е                    | 5.90 | 6.10     |  |  |  |
| E1                   | 3.85 | 3.95     |  |  |  |
| e                    | 1.27 | 1.27 Typ |  |  |  |
| h                    | -    | 0.35     |  |  |  |
| L                    | 0.62 | 0.82     |  |  |  |
| θ                    | 0°   | 8°       |  |  |  |
| All Dimensions in mm |      |          |  |  |  |

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.



| Dimens | ions | Value (in mm) |
|--------|------|---------------|
| Х      |      | 0.60          |
| Y      |      | 1.55          |
| C1     |      | 5.4           |
| C2     |      | 1.27          |

SO-8



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